Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	-
09/823,410	CHIN, HON WAH	
Examiner	Art Unit	-
YOUNG T. TSE	2637	

SEARCHED				
Class	Subclass	Date	Examiner	
375	225, 238- 239, 282, 333	7/7/2005	ΥT	
375	360-361	İ		
370	212-213			
370	232-234			
329	312, 313			
329	314			
332	109-114			
341	61, 68-70			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST and Inventors Name Search	7/7/2005	ΥT